

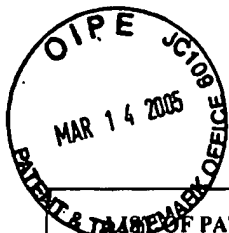
<b>LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT</b> (Use several sheets if necessary)		ATTY DOCKET NO.: E30.2Q-8140- US16		APPLICATION NO.: 10/609242		
		APPLICANT: John C. Pedersen				
		FILING DATE: June 27, 2003		GROUP: 2636		
REFERENCE DESIGNATION			U.S. PATENT AND PUBLISHED APPLICATION DOCUMENTS			
EXAM'S INIT.		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE IF APPROPRIATE
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					
	AL					
FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY		
	BA	GB 2 139 340 A	11/07/1984	United Kingdom		
	BB	06-333403	12/02/1994	Japan		
	BC	08-002341	01/09/1996	Japan		
	BD					
	BE					
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
	CA					
	CB					
	CC					
EXAMINER		DATE CONSIDERED		4/1/05		
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1 of 1



UNPUBLISHED US APPLICATIONS NOT RELATED BY PRIORITY (COPIES ENCLOSED)		ATTY DOCKET NO.: E30.2Q-8140-US16		APPLICATION NO. 10/609242		
		APPLICANT: John C. Pederson				
		FILING DATE: June 27, 2003		GROUP: 2636		
UNPUBLISHED US APPLICATIONS NOT RELATED BY PRIORITY						
EXAM'S INIT.		APPLICATION NO.	FILING DATE	INVENTOR(S)		
	DA					
	DB					
	DC					
	DD					
	DE					
EXAMINER				DATE CONSIDERED		
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US APPLICATIONS RELATED BY PRIORITY (COPIES NOT ENCLOSED)		ATTY DOCKET NO.: E30.2Q-8140-US16		APPLICATION NO. 10/609242		
		APPLICANT: John C. Pederson				
		FILING DATE: June 27, 2003		GROUP: 2636		
US APPLICATIONS RELATED BY PRIORITY						
EXAM'S INIT		APPLICATION NO.	FILING DATE	PATENT NO.	INVENTOR(S)	FORM 1449/892 ENC
JZ	EA	09/590610	06/09/2000	6590502	John C. Pederson	Yes
	EB					
	EC					
	ED					
	EE					
	EF					
EXAMINER			DATE CONSIDERED 4/15/05			
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<b>OFFICE OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT</b> (Use several sheets if necessary)				ATTY DOCKET NO.: E30.2Q-8140-US16		APPLICATION NO.: 10/609242	
				APPLICANT: John C. Pederson			
				FILING DATE: June 27, 2003		GROUP: 2636	
<b>REFERENCE DESIGNATION</b>				<b>U.S. PATENT AND PUBLISHED APPLICATION DOCUMENTS</b>			
EXAM'S INIT.		DOCUMENT NUMBER	DATE	NAME	CLASS/SUBCLASS	FILING DATE IF APPROPRIATE	
	AA						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY			
	BA	0531184A1	03/10/1993	EUROPE (includes English Abstract)			
	BB	0531185A1	03/10/1993	EUROPE (includes English Abstract)			
	BC	0596782A1	05/11/1994	EUROPE (includes English Abstract)			
	BD	0633163A1	01/11/1995	EUROPE (includes English Abstract)			
	BE	0688696A2	12/27/1995	EUROPE (includes English Abstract)			
	BF	0793403B1	09/03/1997	EUROPE (includes English Abstract)			
	BG	0896898A2	07/17/1998	EUROPE (includes English Abstract)			
	BH	FR2658024	08/09/1991	FRANCE (includes English Abstract)			
	BI	FR2680861	03/05/1993	FRANCE (includes English Abstract)			
	BJ	FR2707222	01/13/1995	FRANCE (includes English Abstract)			
	BK	FR2800500	05/04/2001	FRANCE (includes English Abstract)			
	BL	DE4304216	08/18/1994	GERMANY (includes English Abstract)			
	BM	DE29712281	01/22/1998	GERMANY (includes English Abstract)			
	BN	JP60143150	07/29/1985	JAPAN (includes English Abstract)			
	BO	JP6333403	12/02/1994	JAPAN (includes English Abstract)			
	BP	JP8002341	01/09/1996	JAPAN (includes English Abstract)			
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Ect.)</b>							
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EXAM'S INIT.		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE IF APPROPRIATE
✓	AB	3469686	09/30/1969	H.W. Gutsche et al.	—	
1	ACC	3705316	12/05/1972	Burrous et al.	307/311	
	AE	3867718	02/18/1975	Moe		
	AG	4254453	03/03/1981	Mouyard et al.		
	AH	4271408	06/02/1981	Teshima et al.		
	AL	4336580	06/22/1982	Mouyard et al.		
	AO	4434510	02/28/1984	Lemelson	455/603	
	AP	4445132	04/24/1984	Ichikawa et al.	357/32	
	APP	4556862	12/03/1985	Meinershagen	340/67	
	AR	4614866	09/30/1986	Liss et al.	250/214	
	AD	4710977	12/01/1987	Lemelson	455/603	
	AG	4724312	02/09/1988	Snaper	250/203	
	AH	4742432	05/03/1988	Thillays et al.		
	AJ	4821338	04/11/1989	Naruse et al.	455/617	
	AK	4868719	09/19/1989	Kouchi et al.		
	AM	4928084	05/22/1990	Reiser		
	AS	4975814	12/04/1990	Schairer		
	AU	5000569	03/19/1991	Nylund	356/237	
	AA	5038406	08/06/1991	Titterton et al.	359/113	
	AB	5041947	08/20/1991	Yuen et al.	—	
	AE	5060303	10/22/1991	Wilmoth	359/152	
	AF	5067788	11/26/1991	Jannson et al.	385/2	
	AFF	5091828	2/25/92	Jincks et al.	—	
	AM	5159486	10/27/1992	Webb	359/229	
	ANN	5198756	03/30/1993	Gyugyi et al	323/207	
	AP	5224773	07/06/1993	Arimura	362/227	
✓	AT	5291196	03/01/1994	Defour	340/961	
EXAMINER				DATE CONSIDERED		
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EXAM'S INIT.		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE IF APPROPRIATE
82	AU	5298738	03/29/1994	Gebert et al.	250/222	
	AV	5302965	04/12/1994	Belcher et al.	345/31	
	AF	5361190	11/10/1994	Roberts et al.	362/61	
	AH	5400140	03/21/1995	Johnston	356/345	
	AK	5410328	04/25/1995	Yoksza et al.	345/82	
	AL	5410453	04/25/1995	Ruskouski	—	
	AM	5416627	05/16/1995	Wilmoth	359/159	
	AP	5422623	06/06/1995	Bader et al.	340/331	
	AQ	5426417	06/20/1995	Stanuch	—	
	AR	5434693	07/18/1995	Tanaka et al.	359/180	
	AS	5436809	07/25/1995	Brassier et al.	—	
	AU	5465142	11/07/1995	Krumes et al.	356/5.01	
	AV	5471371	11/28/1995	Koppolu et al.	—	
	AC	5490049	02/06/1996	Montalan et al.	362/240	
	AJ	5532472	07/02/1996	Furuta	250/214	
	AN	5580156	12/03/1996	Suzuki et al.	362/184	
	APP	5593459	01/14/97	Gamblin	8/539	
	AQ	5594415	01/14/1997	Iskikawa et al.	—	
	AR	5604480	02/18/1997	Lamparter	—	
	AS	5606444	02/25/1997	Johnson et al.	359/152	
	AT	5612201	03/18/1997	De Plaen et al.		
	ABB	5634287	06/03/1997	Lamparter		
	ACC	5643357	06/03/1997	Nutter et al.		
	ADD	5635902	06/03/1997	Hochstein		
	AE	5636916	06/10/1997	Sokolowski		
	AG	5660461	08/26/1997	Ignatius et al.		
✓	AII	5664448	09/09/1997	Swan et al.		
EXAMINER <i>[Signature]</i>			DATE CONSIDERED <i>1/15/05</i>			
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EXAM'S INIT.		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE IF APPROPRIATE
JL	AO	5726535	03/10/1998	Yan	315/185	
	AP	5726786	03/10/1998	Heflinger	359/152	
	AQ	5734343	03/31/1998	Urbish et al.	340/942	
	AR	5736925	04/07/1998	Knauff et al.	340/468	
	AA	5785418	07/28/1998	Hochstein	362/373	
	AB	5786918	07/28/1998	Suzuki et al.	359/135	
	AI	5808592	09/15/1998	Mizutani et al.	345/83	
	AJ	5826965	10/27/1998	Lyons	362/74	
	AK	5828055	07/27/1998	Jebens	250/214	
	AN	5838259	11/17/1998	Tonkin		
	AP	5872646	02/16/1999	Alserman et al.	359/169	
	AR	5900850	05/04/1999	Bailery et al.	345/55	
	AS	5917637	06/29/1999	Iskikawa et al.	359/181	
	AV	5931570	08/03/1999	Yamuro	362/355	
	AA	5932860	08/03/1999	Plesko	235/454	
	AC	5939996	08/17/1999	Kniveton et al.	340/815.4	
	AD	5959752	09/28/1999	Ota	359/152	
	AE	5960135	09/28/1999	Ozawa	385/24	
	AF	5965879	12/10/1999	Leviton	250/231.13	
	AG	5966073	10/12/1999	Walton		
	AI	5990802 <sup>o</sup>	11/23/1999	Maskeny	340/815.45	
	AK	6014237	01/11/2000	Abeles et al.	359/124	
	AN	6067010	05/23/2000	Wang		
	AO	6067011	05/23/2000	Leslie		
	AP	6067018	05/23/2000	Skelton et al.	340/573.3	
	APP	6086229	07/1/2000	Pastrick	362/494	
	AQ	6091025	07/18/2000	Cotter et al.	174/110	
↓	AT	6106137	08/22/2000	Adams et al.		
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✓	AU	6118388	09/12/2000	Morrison	340/908	
	AA	6159005	12/12/2000	Herold et al.	433/29	
	AB	6166496	12/26/2000	Lys et al.	315/316	
	AD	6183100B1	02/06/2001	Suckow et al.	362/35	
	AE	6243492B1	06/05/2001	Kamei	382/181	
	AF	6249340B1	06/19/2001	Jung et al.	356/73	
	AG	6268788B1	07/31/2001	Gray	340/5.2	
	AH	6271913B1	08/07/2001	Jung et al.	356/73	
	AI	6292575B1	09/18/2001	Bortolussi et al.	382/118	
	AJ	6293904B1	09/25/2001	Blazey et al.	600/26	
	AK	6318886B1	11/20/2001	Stopa et al.	362/555	
	AL	6367949B1	04/09/2002	Pederson	362/240	
	AM	6380865	04/30/2002	Pederson	340/815.45	
	AN	6424269B1	07/23/2002	Pederson	340/815.45	
	ANN	6461008B1	10/08/2002	Pederson	362/542	
	AO	6462669	10/08/2002	Pederson	340/815.45	
	AOO	6469631	10/22/2002	Pederson	340/815.45	
	AP	6472996B1	10/29/2002	Pederson	362/815.45	
	AQ	6547410B1	04/15/2003	Pederson	345/815.45	
	AR	6614359B2	09/02/2003	Pederson	340/815.45	
	ARR	6623151	09/23/2003	Pederson	362/35	
✓	AS	6705745	03/16/2004	Pederson	362/284	
EXAMINER				DATE CONSIDERED	4/15/05	

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